



TWO CONFERENCES. ONE LOCATION.

PLAN TO ATTEND IN AMSTERDAM
SEPTEMBER 2014

SPIE. REMOTE
SENSING

www.spie.org/rs14

SPIE. SECURITY+
DEFENCE

www.spie.org/sd14

Amsterdam RAI Exhibition and Convention Centre
Amsterdam, Netherlands

Conferences: 22–25 September 2014

Exhibition: 23–24 September 2014

Join us in Amsterdam and participate in Europe's premier event for remote sensing.

SPIE Remote Sensing is a European conference for international scientists and researchers focusing on satellite-based imaging systems and the data generated by them; an opportunity to apply technology to industry.

SPIE. REMOTE SENSING

MORE THAN 550 PRESENTATIONS IN THESE TOPIC AREAS:

Atmospheric Sensing
Earth Surface Sensing
Platforms and Systems
Environmental Monitoring and Applications

HOT TOPICS INCLUDE:

Sentinel 1 Satellite News & Updates
Special Session: 50th Anniversary of TNO Space

PLENARY SESSION:

Remote Sensing at the NASA Kennedy Space Center: A Perspective from the Ground Up

LISA HUDDLESTON,
NASA KSC Weather Office (United States)

50 years of Space Instrumentation Development in the Netherlands

BART SNIJDERS
TNO (Netherlands)

2014 SYMPOSIUM CHAIR



CHARLES R. BOSTATER
Marine-Environmental Optics
Lab & Remote Sensing Center,
Florida Institute of Technology
(United States)

2014 SYMPOSIUM CO-CHAIRS



ULRICH MICHEL
University of Education
Heidelberg (Germany)



BART SNIJDERS
TNO
(Netherlands)

REMOTE SENSING COOPERATING ORGANISATIONS:



Hear the latest technological advances in Europe's leading Security and Defence meeting.

SPIE Security + Defence is a conference for international engineers, researchers and scientists involved in optical science and applied technologies in advanced security and defence systems; bringing production to practice.



Please join us at the
Security + Defence Exhibition
Tuesday 23 September, 10:00 to 17:00
Wednesday 24 September, 10:00 to 16:00

MORE THAN 200 PRESENTATIONS IN THESE TOPIC AREAS:

- Infrared Systems
- Electro-optical Remote Sensing
- Biological and Chemical Sensing
- Unmanned/Unattended Sensors
- Imaging and Display Technologies
- Optical Materials and Technologies
- High-Power Lasers - Technology Systems

PLENARY SESSION:

Integrated Circuit Lithography

JOS BENSCHOP

ASML (Netherlands)

Image Processing and
Image Interpretation

PETER de WITH,

Technische Univ. Eindhoven (Netherlands)

2014 SYMPOSIUM CHAIR



DAVID H. TITTERTON

Defence Science
and Technology Lab.
(United Kingdom)

2014 SYMPOSIUM CO-CHAIRS



REINHARD EBERT

Fraunhofer-Institut für
Optronik, Systemtechnik
und Bildauswertung
(Germany)



RIC SCHLEIJPEN

TNO Defence,
Security and Safety
(Netherlands)

SECURITY + DEFENCE COOPERATING ORGANISATION:



One registration fee gains you access to all the presentations at these co-located events, along with free admission to the exhibition.

**REGISTER
TODAY**

22-25 SEPTEMBER 2014

Plan to attend these two
premier European events.

Amsterdam RAI Exhibition and
Convention Centre
Amsterdam, Netherlands

SPIE. REMOTE
SENSING

www.spie.org/rs

SPIE. SECURITY+
DEFENCE

www.spie.org/sd

SPIE.EUROPE

2 Alexandra Gate, Ffordd Pengam,
Cardiff, CF24 2SA, UK